

## Notic of References Cited

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10/056,865	Reexamination YOSHIDA ET AL.	
Examiner	Art Unit	
Donald M. Lair	2858	Page 1 of 1

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	В	US-2002/0131342	09-2002	Kadlec et al.	369/44.29
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	К	US-			
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NON-PATENT DOCUMENTS				
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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